



(14.82 %, 12.16 %, 26.55 %, or 23.69 %)-Limiting Highest Efficiencies, obtained respectively in $n^+(p^+) - p(n)$ Crystalline ($X \equiv \text{Ge, GaSb, CdTe, or CdSe}$)-Junction Solar Cells, Due to the Effects of Impurity Size, Temperature, Heavy Doping, and Photovoltaic Conversion

H. Van Cong

Université de Perpignan Via Domitia, Laboratoire de Mathématiques et Physique (LAMPS), EA 4217, Département de Physique, 52, Avenue Paul Alduy, F-66 860 Perpignan, France.

Email: van-cong.huynh@univ-perp.fr ; huynhv@outlook.fr

Abstract:

In the $n^+(p^+) - p(n)$ crystalline ($X \equiv \text{Ge, GaSb, CdTe or CdSe}$)-junction solar cells at 300K, due to the effects of impurity size, temperature, heavy doping, and photovoltaic conversion, we show that, with an increasing donor (acceptor)-radius $r_{d(a)}$, both the relative dielectric constant and photovoltaic conversion factor decrease, and the intrinsic band gap (IBG) increases, according to the increase in photovoltaic efficiency, as observed in Tables 1-5, being in good accordance with an important result obtained by Shockley and Queisser [10], stating that for an increasing IBG the photovoltaic efficiency increases.

Further, for highest values of $r_{d(a)}$, the limiting highest efficiencies are found to be given in Tables 2.2, 3.2, 4.2, and 5.2, as: 14.82 %, 12.16 %, 26.55 %, and 23.69 %, obtained in such $n^+(p^+) - p(n)$ crystalline (Ge, GaSb, CdTe, or CdSe)-junction solar cells at the open circuit voltage $V_{oc} = 0.33 \text{ V, } 0.355 \text{ V, } 0.82 \text{ V, and } 0.89 \text{ V}$, respectively, and at $T=300 \text{ K}$.

Furthermore, from the well-known Carnot-efficiency theorem, as given in Eq. (46), being obtained from the second principle of the thermodynamics, and from the above results of limiting highest efficiencies, the corresponding highest hot reservoir temperatures, $T_H = 352.2 \text{ K, } 341.5 \text{ K, } 408.4 \text{ K, and } 393.1 \text{ K}$, respectively. Thus, as noted above, η_{\max} and T_H both increase with an increasing IBG, for each ($X \equiv \text{Ge, GaSb, CdTe, or CdSe}$)- crystal at $T=300 \text{ K} \equiv T_C$.

Keywords: donor (acceptor)-size effect; heavily doped emitter region; photovoltaic conversion factor; open circuit voltage; efficiency

1.Introduction

In the present work, the limiting highest efficiencies, $\eta_{I(II)}$, due to the effects of impurity size, temperature, heavy doping, and photovoltaic conversion, will be investigated respectively in the heavily doped donor (acceptor)-X emitter-and-lightly doped acceptor (donor)-X base-regions, HD[d(a)-X]ER-LD[a(d)-X]BR, $X \equiv (\text{Ge}, \text{GaSb}, \text{CdTe}, \text{or CdSe})$ -crystal, of $n^+(p^+) - p(n)$ junction solar cells; it is inspired from other works [1-21].

For each d(a)-X-crystal [1], one notes that: (i) due to the effect of donor (acceptor) d(a)- radius $r_{d(a)}$, with an increasing $r_{d(a)}$, the relative dielectric constant $\epsilon(r_{d(a)})$ decreases, while the band gap (BG), $E_{gn(gp)}(r_{d(a)})$, increases, as observed in Equations (1.1, 1.2, ..., 1.4), (ii) due the temperature (T)-effect, the intrinsic BG (IBG), $E_{gin(gip)}(T, r_{d(a)})$, decreases with increasing T, as given in Eq. (3), and (iii) due to the effect of heavy doping, with increasing d(a)-density, $N_{d(a)}$, while the Fermi energy increases, as given in Eq. (5), the BG is reduced by the BG narrowing, as observed in Equations (6) and (7). Therefore, as remarked in Section 5, the dark carrier-minority saturation current density, $J_{ol(oII)}(W, N_{d(a)}, r_{d(a)}, S; N_{a(d)}, r_{a(d)})$, defined in Eq. (37), decreases with increasing IBG, or with increasing $r_{d(a)}$, given in the ER(BR).

Then, for each d(a)-X-crystal, the photovoltaic conversion effect converts the light, represented by the short circuit current density, defined in Eq. (41), $J_{scl(sclII)}(W, N_{d(a)}, r_{d(a)}, S; N_{a(d)}, r_{a(d)}; V_{oc})$, V_{oc} being the open circuit voltage, into the electricity, by $J_{ol(oII)}$.

Further, as observed in Tables 2.1, 2.2, ..., 5.1, 5.2, for a given V_{oc} , the photovoltaic conversion factor (PVCF), determined in Eq. (42), $n_{I(II)}(W, N_{d(a)}, r_{d(a)}, S; N_{a(d)}, r_{a(d)}; V_{oc})$, decreases with increasing IBG, or with increasing $r_{d(a)}$, according to the increase in $J_{scl(sclII)}$, in the fill factor, $F_{I(II)}(W, N_{d(a)}, r_{d(a)}, S; N_{a(d)}, r_{a(d)}; V_{oc})$ and the efficiency $\eta_{I(II)}(W, N_{d(a)}, r_{d(a)}, S; N_{a(d)}, r_{a(d)}; V_{oc})$, defined respectively in Equations (43, 44). This remark is found to be in accordance with an important result obtained by Shockley and Queisser [10], stating that for an increasing IBG, η increases.

2. Effects of Impurity Size, Temperature and Heavy Doping

First of all, in intrinsic X-crystals at temperature $T(=0 \text{ K})$ [5-9, 11-21], $X \equiv (\text{Ge}, \text{GaSb}, \text{CdTe}, \text{or CdSe})$, and at $r_{d(a)} = r_{do(ao)}$, the values of relative dielectric constant, $\epsilon(r_{d(a)}) = \epsilon(r_{d(a)} = r_{do(ao)}) = \epsilon_o$, effective average number of equivalent conduction (valence)-band edges, $g_{c(v)}$, relative effective electron (hole) mass in conduction (valence) bands, $(m_{c(v)}/m_o)$, unperturbed intrinsic band gap, E_{go} , and effective ionization energies in absolute values, $E_{do(ao)} = \frac{13600 \times (m_{c(v)}/m_o)}{(\epsilon_o)^2} \text{ meV}$, are given Tables 1.1, 1.2, 1.3, 1.4.

2.1. Impurity-Size Effect

In such d(a)-X systems at $T=0 \text{ K}$, since $r_{d(a)}$, in tetrahedral covalent bonds, is usually either larger or smaller than $r_{do(ao)}$, a local mechanical strain (or deformation potential energy) is induced, according to a

compression (or a dilation), for $r_{d(a)} > r_{do(ao)}$ (for $r_{d(a)} < r_{do(ao)}$), respectively, due to the d(a)-size effect, as that investigated in [1]. Further, in n(p)-type X crystals, the band gap $E_{gn(gp)}(r_{d(a)})$ and the effective donor (acceptor)-ionization energy $E_{d(a)}(r_{d(a)})$ are expressed as:

$$\text{for } r_{d(a)} \geq r_{do(ao)}, \text{ since } \varepsilon(r_{d(a)}) = \frac{\varepsilon_o}{\sqrt{1 + \left[\left(\frac{r_{d(a)}}{r_{do(ao)}}\right)^3 - 1\right] \times \ln\left(\frac{r_{d(a)}}{r_{do(ao)}}\right)^3}} \leq \varepsilon_o,$$

$$E_{gn(gp)}(r_{d(a)}) - E_{go} = E_{d(a)}(r_{d(a)}) - E_{do(ao)} = E_{do(ao)} \times \left[\left(\frac{\varepsilon_o}{\varepsilon(r_{d(a)})} \right)^2 - 1 \right], \quad (1)$$

according to the increase in both $E_{gn(gp)}$ and $E_{d(a)}(r_{d(a)})$,

$$\text{and for } r_{d(a)} \leq r_{do(ao)}, \text{ since } \varepsilon(r_{d(a)}) = \frac{\varepsilon_o}{\sqrt{1 - \left[\left(\frac{r_{d(a)}}{r_{do(ao)}}\right)^3 - 1\right] \times \ln\left(\frac{r_{d(a)}}{r_{do(ao)}}\right)^3}} \geq \varepsilon_o, \left[\left(\frac{r_{d(a)}}{r_{do(ao)}} \right)^3 - 1 \right] \times \ln\left(\frac{r_{d(a)}}{r_{do(ao)}}\right)^3 < 1,$$

$$E_{gn(gp)}(r_{d(a)}) - E_{go} = E_{d(a)}(r_{d(a)}) - E_{do(ao)} = E_{do(ao)} \times \left[\left(\frac{\varepsilon_o}{\varepsilon(r_{d(a)})} \right)^2 - 1 \right], \quad (2)$$

corresponding to the decrease in both $E_{gn(gp)}$ and $E_{d(a)}(r_{d(a)})$.

2.2. Temperature Effect

Here, the intrinsic band gap in the X-crystal is found to be given respectively by [3, 8]:

$$E_{gin(gip)}(T, r_{d(a)}) = E_{gn(gp)}(r_{d(a)}) - \frac{\alpha \times 10^{-4} \times T^2}{T + \beta}, \quad (3)$$

$\alpha = 4.561, 3.6773, 4.465, 4.3779$, and $\beta = 210 \text{ K}, 94 \text{ K}, 94 \text{ K}, 94 \text{ K}$.

Further, one can define the intrinsic carrier concentration $n_{in(ip)}$ by:

$$n_{in(ip)}^2(T, r_{d(a)}) \equiv N_c(T) \times N_v(T) \times \exp\left(\frac{-E_{gin(gip)}(T, r_{d(a)})}{k_B T}\right), \quad (4)$$

where $N_{c(v)}(T) = 2 \times g_{c(v)} \times \left(\frac{m_{c(v)} \times k_B T}{2\pi\hbar^2}\right)^{\frac{3}{2}}$ (cm^{-3}) are the conduction (valence)-band density of states.

The numerical results of those energy-band structure parameters are given in the following Tables 1.1, 1.2, 1.3, and 1.4.

Table 1.1. From Equations (1-4), and in the n(p)-type Ge crystal, in which $g_{c(v)} = 4(2)$ and $(m_{c(v)}/m_o) = 0.12(0.3)$, the numerical results of the energy-band-structure parameters, due to the effect of impurity size are reported, suggesting that, for $T = 300 \text{ K}$ and with an increasing $r_{d(a)}$, both $\varepsilon(r_{d(a)})$ and $n_{in(ip)}(T, r_{d(a)})$ decrease, while the other ones increase.

Donor		P	As	Ge	Sb	Sn
r_d (nm)	↗	0.110	0.118	$r_{do}=0.122$	0.136	0.140
$\varepsilon(r_d)$	↘	16.499	15.8757	$\varepsilon_o=15.8$	14.8927	14.3575
$E_d(r_d)$ in meV	↗	5.99	6.47	$E_{do}=6.54$	7.36	7.92
$E_{gn}(r_d)$ in eV	↗	0.7407	0.7411	$E_{go}=0.7412$	0.7420	0.7426
$E_{gin}(T = 300\text{K}, r_d)$ in eV	↗	0.660	0.6606	$E_{gio}=0.6607$	0.6615	0.6621
$n_{in}(T = 300\text{K}, r_d)$ in 10^{13}cm^{-3}	↘	1.674	1.659	$n_{io}=1.657$	1.631	1.613
Acceptor		B	Ge	Ga	Mg	In

r_a (nm)	↗	0.088	$r_{ao}=0.122$	0.126	0.140	0.144
$\epsilon(r_a)$	↘	25.3735	$\epsilon_o=15.8$	15.722	14.3575	13.7495
$E_a(r_a)$ in meV	↗	6.34	$E_{ao}=16.3$	16.5	19.8	21.6
$E_{gp}(r_a)$ in eV	↗	0.7312	$E_{go}=0.7412$	0.7414	0.7446	0.7464
$E_{gip}(T = 300K, r_a)$ in eV	↗	0.6507	$E_{gio}=0.6607$	0.6609	0.6642	0.6660
$n_{ip}(T = 300K, r_a)$ in $10^{13}cm^{-3}$	↘	2.011	$n_{io}=1.657$	1.652	1.550	1.497

Table 1.2. From Equations (1-4) and in the n(p)-type GaSb crystal, in which $g_{c(v)} = 1(1)$ and $(m_c/m_o) = 0.047$ and $(m_v/m_o) = 0.3$, the numerical results of the energy-band-structure parameters, due to the effects of T , $r_{d(a)}$, and high $N_{d(a)}$, are reported, suggesting that, with an increasing $r_{d(a)}$, both $\epsilon(r_d)$ and $n_{in}(T, r_d)$ decrease, and then the other ones increase.

Donor (with $N_d = 10^{19} cm^{-3}$)		P	As	Sb	Sn
r_d (nm)	↗	0.110	0.118	$r_{do}=0.136$	0.140
$\epsilon(r_d)$	↘	18.7494	16.9954	$\epsilon_o=15.69$	15.6284
$E_d(r_d)$ in meV	↗	1.8183	2.2130	$E_{do}=2.5965$	2.6170
$E_{gn}(r_d)$ in eV	↗	0.8092	0.8096	$E_{go}=0.81$	0.81002
$E_{gin}(T = 300K, r_d)$ in eV	↗	0.7252	0.7256	$E_{gio}=0.7260$	0.72602
$n_{in}(T = 300K, r_d)$ in $10^{11}cm^{-3}$	↘	8.3297	8.2665	$n_{io}=8.2054$	8.2020
Acceptor (with $N_a = 10^{20} cm^{-3}$)		B	Ga	Mg	In
r_a (nm) [4]	↗	0.088	$r_{ao}=0.126$	0.140	0.144
$\epsilon(r_a)$	↘	29.13	$\epsilon_o=15.69$	14.8422	14.3386
$E_a(r_a)$ in meV	↗	4.80	$E_{ao}=16.57$	18.52	19.84
$E_{gp}(r_a)$ in eV	↗	0.798	$E_{go}=0.81$	0.8119	0.8133
$E_{gip}(T = 300K, r_a)$ in eV	↗	0.7142	$E_{gio}=0.7260$	0.7279	0.7293
$n_{ip}(T = 300K, r_a)$ in $10^{11} cm^{-3}$	↘	10.302	$n_{io}=8.2054$	7.9022	7.7024

Table 1.3. From Equations (1-4) and in the n(p)-type CdTe crystal, in which $g_{c(v)} = 1(1)$ and $(m_c/m_o) = 0.095$ and $(m_v/m_o) = 0.82$, the numerical results of the energy-band-structure parameters, due to the effect of impurity size are reported, suggesting that, for $T= 300$ K and with an increasing $r_{d(a)}$, both $\epsilon(r_{d(a)})$ and $n_{in(ip)}(T, r_{d(a)})$ decrease, while the other ones increase.

Donor		As	Te	Sb	Sn
r_d (nm)	↗	0.118	$r_{do}=0.132$	0.136	0.140
$\epsilon(r_d)$	↘	10.844	$\epsilon_o=10.31$	10.267	10.139
$E_d(r_d)$ in meV	↗	11	$E_{do}=12.2$	12.3	12.6
$E_{gn}(r_d)$ in eV	↗	1.621	$E_{go}=1.622$	1.622	1.6224
$E_{gin}(T = 300K, r_d)$ in eV	↗	1.519	$E_{gio}=1.52$	1.5201	1.5204
$n_{in}(T = 300K, r_d)$ in $10^5 cm^{-3}$	↘	6.485	$n_{io}=6.340$	6.327	6.289

Acceptor		Ga	Mg	In	Cd
r_a (nm)	↗	0.126	0.140	0.144	$r_{ao}=0.148$
$\epsilon(r_a)$	↘	11.419	10.445	10.344	$\epsilon_o=10.31$
$E_a(r_a)$ in meV	↗	85.5	102.2	104.21	$E_{ao}=104.9$
$E_{gp}(r_a)$ in eV	↗	1.603	1.619	1.621	$E_{go}=1.622$
$E_{gip}(T = 300K, r_a)$ in eV	↗	1.501	1.517	1.519	$E_{gio}=1.52$
$n_{ip}(T = 300K, r_a)$ in 10^5cm^{-3}	↘	9.225	6.678	6.424	$n_{io}=6.340$

Table 1.4. From Equations (1-4) and in the n(p)-type CdSe crystal, in which $g_{c(v)} = 1(1)$ and $(m_c/m_o) = 0.11$ and $(m_v/m_o) = 0.45$, the numerical results of the energy-band-structure parameters, due to the effect of impurity size are reported, suggesting that, for $T= 300$ K and with an increasing $r_{d(a)}$, both $\epsilon(r_{d(a)})$ and $n_{in(ip)}(T, r_{d(a)})$ decrease, while the other ones increase.

Donor		Se	Te	Sb	Sn
r_d (nm)	↗	$r_{do}=0.114$	0.132	0.136	0.140
$\epsilon(r_d)$	↘	$\epsilon_o=10.2$	9.149	8.716	8.259
$E_d(r_d)$ in meV	↗	$E_{do}=14.38$	17.87	19.69	21.93
$E_{gn}(r_d)$ in eV	↗	$E_{go}=1.84$	1.843	1.845	1.847
$E_{gin}(T = 300K, r_d)$ in eV	↗	$E_{gio}=1.74$	1.743	1.745	1.747
$n_{in}(T = 300K, r_d)$ in 10^3cm^{-3}	↘	$n_{io}=6.408$	5.989	5.782	5.537

Acceptor		Ga	Mg	In	Cd
r_a (nm)	↗	0.126	0.140	0.144	$r_{ao}=0.148$
$\epsilon(r_a)$	↘	11.298	10.333	10.233	$\epsilon_o=10.2$
$E_a(r_a)$ in meV	↗	47.95	57.32	58.44	$E_{ao}=58.82$
$E_{gp}(r_a)$ in eV	↗	1.829	1.838	1.8396	$E_{go}=1.84$
$E_{gip}(T = 300K, r_a)$ in eV	↗	1.729	1.738	1.7396	$E_{gio}=1.74$
$n_{ip}(T = 300K, r_a)$ in 10^3cm^{-3}	↘	7.908	6.597	6.455	$n_{io}=6.408$

2.3. Heavy Doping Effect

Here, the Fermi energy $E_{Fn}(-E_{Fp})$, band gap narrowing (BGN), and apparent band gap narrowing (ABGN), as those determined in P1, are reported in the following.

First, the Fermi energy $E_{Fn}(-E_{Fp})$, obtained for any T and any $d(a)$ -density, $N_{d(a)}$, being investigated in our previous paper [17], with a precision of the order of 2.11×10^{-4} is found to be given by:

$$\frac{E_{Fn}(u)}{k_B T} \left(\frac{-E_{Fp}(u)}{k_B T} \right) = \frac{G(u) + A u^B F(u)}{1 + A u^B}, \quad A = 0.0005372 \text{ and } B = 4.82842262, \quad (5)$$

where u is the reduced electron density, $u \equiv \frac{N_{d(a)}}{N_{c(v)}}$, $F(u) = au^{\frac{2}{3}} \left(1 + bu^{-\frac{4}{3}} + cu^{-\frac{8}{3}} \right)^{-\frac{2}{3}}$, $a = [(3\sqrt{\pi}/4) \times u]^{2/3}$,

$$b = \frac{1}{8} \left(\frac{\pi}{a} \right)^2, \quad c = \frac{62.3739855}{1920} \left(\frac{\pi}{a} \right)^4, \quad \text{and} \quad G(u) \simeq \ln(u) + 2^{-\frac{3}{2}} \times u \times e^{-du}; \quad d = 2^{3/2} \left[\frac{1}{\sqrt{27}} - \frac{3}{16} \right] > 0.$$

Here, one notes that: (i) as $u \gg 1$, according to the HD[d(a)-X]ER-case, or to the degenerate case, Eq. (5) is reduced to the function $F(u)$, and (ii) $\frac{E_{Fn}(u \ll 1)}{k_B T} \left(\frac{-E_{Fp}(u \ll 1)}{k_B T} \right) \ll -1$, to the LD[a(d)-X]BR-case, or to the non-degenerate case, Eq. (5) is reduced to the function $G(u)$.

Secondly, if denoting the effective Wigner-Seitz radius r_s , characteristic of the interactions, by:

$$r_{sn(sp)}(N_{d(a)}, r_{d(a)}) = 1.1723 \times 10^8 \times \left(\frac{g_{c(v)}}{N_{d(a)}} \right)^{1/3} \times \frac{m_{c(v)}}{\epsilon(r_{d(a)})},$$

the correlation energy of an effective electron gas, $E_{cn(cp)}(N_{d(a)}, r_{d(a)})$, is given as [1]:

$$E_{cn(cp)}(N_{d(a)}, r_{d(a)}) = \frac{-0.87553}{0.0908 + r_{sn(sp)}} + \frac{\frac{0.87553}{0.0908 + r_{sn(sp)}} + \left(\frac{2[1 - \ln(2)]}{\pi^2} \right) \times \ln(r_{sn(sp)}) - 0.093288}{1 + 0.03847728 \times r_{sn(sp)}^{1.67378876}}.$$

Now, taking into account various spin-polarized chemical potential-energy contributions [12] such as: exchange energy of an effective electron (hole) gas, majority-carrier correlation energy of an effective electron (hole) gas, minority hole (electron) correlation energy, majority electron (hole)-ionized d(a) interaction screened Coulomb potential energy, and finally minority hole (electron)-ionized d(a) interaction screened Coulomb potential energy, the band gap narrowing (BGN) are given as follows.

Then, in the n-type heavily doped X-crystals, the BGN is found to be given by:

$$\Delta E_{gn}(N_d, r_d) \simeq a_1 \times \frac{\epsilon_0}{\epsilon(r_d)} \times N_r^{1/3} + a_2 \times \frac{\epsilon_0}{\epsilon(r_d)} \times N_r^{\frac{1}{3}} \times (2.503 \times [-E_c(r_{sn}) \times r_{sn}]) + a_3 \times \left[\frac{\epsilon_0}{\epsilon(r_d)} \right]^{5/4} \times \sqrt{\frac{m_c}{m_v}} \times N_r^{1/4} + a_4 \times \sqrt{\frac{\epsilon_0}{\epsilon(r_d)}} \times N_r^{1/2} \times 2 + a_5 \times \left[\frac{\epsilon_0}{\epsilon(r_d)} \right]^{\frac{3}{2}} \times N_r^{\frac{1}{6}}, \quad N_r \equiv \left(\frac{N_d}{9.999 \times 10^{17} \text{ cm}^{-3}} \right), \quad (6)$$

where $a_1 = 3.8 \times 10^{-3}(\text{eV})$, $a_2 = 6.5 \times 10^{-4}(\text{eV})$, $a_3 = 2.8 \times 10^{-3}(\text{eV})$, $a_4 = 5.597 \times 10^{-3}(\text{eV})$ and $a_5 = 8.1 \times 10^{-4}(\text{eV})$, and in the p-type heavily doped X-crystals, as:

$$\Delta E_{gp}(N_a, r_a) \simeq a_1 \times \frac{\epsilon_0}{\epsilon(r_a)} \times N_r^{1/3} + a_2 \times \frac{\epsilon_0}{\epsilon(r_a)} \times N_r^{\frac{1}{3}} \times (2.503 \times [-E_c(r_{sp}) \times r_{sp}]) + a_3 \times \left[\frac{\epsilon_0}{\epsilon(r_a)} \right]^{5/4} \times \sqrt{\frac{m_c}{m_v}} \times N_r^{1/4} + 2a_4 \times \sqrt{\frac{\epsilon_0}{\epsilon(r_a)}} \times N_r^{1/2} + a_5 \times \left[\frac{\epsilon_0}{\epsilon(r_a)} \right]^{\frac{3}{2}} \times N_r^{\frac{1}{6}}, \quad N_r \equiv \left(\frac{N_a}{9.999 \times 10^{17} \text{ cm}^{-3}} \right), \quad (7)$$

where $a_1 = 3.15 \times 10^{-3}(\text{eV})$, $a_2 = 5.41 \times 10^{-4}(\text{eV})$, $a_3 = 2.32 \times 10^{-3}(\text{eV})$, $a_4 = 4.12 \times 10^{-3}(\text{eV})$ and $a_5 = 9.80 \times 10^{-5}(\text{eV})$.

Therefore, in the HD[d(a)-X]ER, we can define the effective extrinsic carrier concentration, $n_{en(ep)}^*$, by :

$$n_{en(ep)}^*(N_{d(a)}, T, r_{d(a)}) \equiv \sqrt{N_{d(a)} \times p_o(n_o)} = n_{in(ip)} \times \exp \left[\frac{\Delta E_{agn(aggp)}}{2k_B T} \right], \quad (8)$$

where the apparent band gap narrowing (ABGN), $\Delta E_{agn(aggp)}$, is defined by:

$$\Delta E_{agn}(N_d, T, r_d) \equiv \Delta E_{gn} + k_B T \times \ln \left(\frac{N_d}{N_c} \right) - E_{Fn}(N_d, T),$$

$$\Delta E_{aggp}(N_a, T, r_a) \equiv \Delta E_{gp} + k_B T \times \ln \left(\frac{N_a}{N_v} \right) + E_{Fp}(N_a, T). \quad (9)$$

3. Total minority-carrier saturation current density

In the two $n^+(p^+) - p(n)$ X-junction solar cells, denoted respectively by I(II), the total carrier-minority saturation current density is defined by:

$$J_{ol(olI)} \equiv J_{Eno(Epo)} + J_{Bpo(Bno)} \quad (10)$$

where $J_{Bpo(Bno)}$ is the minority-electron (hole) saturation current density injected into the LD[a(d)-X]BR, and $J_{Eno(Epo)}$ is the minority-hole (electron) saturation-current density injected into the HD[d(a)-X]ER.

3.1. $J_{Bpo(Bno)}$ in the LD[a(d)-X]BR

Here, $J_{Bpo(Bno)}$ is determined by [13]:

$$J_{Bpo(Bno)}(N_{a(d)}, r_{a(d)}) = \frac{e \times n_{ip(in)}^2(r_{a(d)}) \times \sqrt{\frac{D_{e(h)}(N_{a(d)}, r_{a(d)})}{\tau_{eB(hB)}(N_{a(d)})}}}{N_{a(d)}}, \quad (11)$$

where $n_{ip(in)}^2(r_{d(a)})$ is determined in Tables 1.1, 1.2, 1.3 and 1.4, $D_{e(h)}(N_{a(d)}, r_{a(d)})$ is the minority electron (minority hole) diffusion coefficient:

$$D_e(N_a, r_a) = \frac{k_B T}{e} \times \left[850 + \frac{5750}{1 + \left(\frac{N_a}{8 \times 10^{17} \text{ cm}^{-3}} \right)^{1.8}} \right] \times \left(\frac{\epsilon(r_a)}{\epsilon_o} \right)^2 (\text{cm}^2 \text{s}^{-1}), \quad (12)$$

$$D_h(N_d, r_d) = \frac{k_B T}{e} \times \left[85 + \frac{1165}{1 + \left(\frac{N_d}{4 \times 10^{17} \text{ cm}^{-3}} \right)^{0.44}} \right] \times \left(\frac{\epsilon(r_d)}{\epsilon_o} \right)^2 (\text{cm}^2 \text{s}^{-1}), \quad (13)$$

and $\tau_{eB(hB)}(N_{a(d)})$ is the minority electron (minority hole) lifetime in the BR:

$$\tau_{eB}(N_a)^{-1} = \frac{1}{10^{-7}} + 3 \times 10^{-13} \times N_a + 1.83 \times 10^{-31} \times N_a^2, \quad (14)$$

$$\tau_{hB}(N_d)^{-1} = \frac{1}{10^{-7}} + 11.76 \times 10^{-13} \times N_d + 2.78 \times 10^{-31} \times N_d^2. \quad (15)$$

3.2. $J_{Eno(Epo)}$ in the HD[d(a)-GaSb]ER

In the non-uniformly and heavily doped emitter region of d(a)-X devices, the effective Gaussian d(a)-density profile or the d(a) (majority-e(h)) density, is defined in such the HD[d(a)-X]ER-width W , as [1]:

$$\rho_{d(a)}(x, N_{d(a)}, W) = N_{d(a)} \times \exp \left\{ - \left(\frac{x}{W} \right)^2 \times \ln \left[\frac{N_{d(a)}}{N_{do(ao)}(W)} \right] \right\} \equiv N_{d(a)} \times \left[\frac{N_{d(a)}}{N_{do(ao)}(W)} \right]^{-\left(\frac{x}{W} \right)^2}, \quad 0 \leq x \leq W, \quad (16)$$

$$N_{do(ao)}(W) \equiv 7.9 \times 10^{17} (2 \times 10^5) \times \exp \left\{ - \left(\frac{W}{184.2 (1) \times 10^{-7} \text{ cm}} \right)^{1.066 (0.5)} \right\} (\text{cm}^{-3}),$$

where $\rho_{d(a)}(x=0) = N_{d(a)}$ is the surface d(a)-density, and at the emitter-base junction, $\rho_{d(a)}(x=W) = N_{do(ao)}(W)$, which decreases with increasing W . Further, the “effective doping density” is defined by:

$$N_{d(a)}^*(x, r_{d(a)}) \equiv \rho_{d(a)}(x) / \exp \left[\frac{\Delta E_{agn(agg)}(\rho_{d(a)}, r_{d(a)})}{k_B T} \right],$$

$$N_{d(a)}^*(x=0, r_{d(a)}) \equiv \frac{N_{d(a)}}{\exp \left[\frac{\Delta E_{agn(agg)}(N_{d(a)}, r_{d(a)})}{k_B T} \right]}, \text{ and}$$

$$N_{d(a)}^*(x = W, r_{d(a)}) \equiv \frac{N_{do(ao)}(W)}{\exp\left[\frac{\Delta E_{agn(agg)}(N_{do(ao)}(W), r_{d(a)})}{k_B T}\right]}, \quad (17)$$

where the apparent band gap narrowing $\Delta E_{agn(agg)}$ is determined in Eq. (9), replacing $N_{d(a)}$ by $\rho_{d(a)}(x, N_{d(a)}, W)$. The same remark can be applied to following Equations (18-20).

Now, we can define the minority hole (minority electron) transport parameter $F_{h(e)}$ as:

$$F_{h(e)}(N_{d(a)}, r_{d(a)}) \equiv \frac{n_{in(ip)}^2(T, r_{d(a)})}{p_o(n_o) \times D_{h(e)}} = \frac{N_{d(a)}^*}{D_{h(e)}} = \frac{N_{d(a)}}{D_{h(e)}} \times \left(\frac{n_{in(ip)}}{n_{in(ip)}^*}\right)^2 \equiv \frac{N_{d(a)}}{D_{h(e)} \times \exp\left[\frac{\Delta E_{agn(agg)}}{k_B T}\right]} \text{ (cm}^{-5} \times \text{s)}, \quad (18)$$

the minority hole (electron) diffusion length, $L_{h(e)}(N_{d(a)}, r_{d(a)})$ by:

$$L_{h(e)}^{-2}(N_{d(a)}, r_{d(a)}) = [\tau_{hE(eE)} \times D_{h(e)}]^{-1} = (C \times F_{h(e)})^2 = \left(C \times \frac{N_{d(a)}^*}{D_{h(e)}}\right)^2 = \left(C \times \frac{n_{in(ip)}^2(r_{d(a)})}{p_o(n_o) \times D_{h(e)}}\right)^2, \quad (19)$$

where the constant C was chosen to be equal to: $2.0893 \times 10^{-30} \text{ (cm}^4/\text{s)}$, and the minority hole (minority electron) lifetime $\tau_{hE(eE)}$ as:

$$\tau_{hE(eE)} \equiv \frac{1}{D_{h(e)} \times L_{h(e)}^{-2}} = \frac{1}{D_{h(e)} \times (C \times F_{h(e)})^2}. \quad (20)$$

Then, under low-level injection, in the absence of external generation, and for the steady-state case, we can define the minority-h(e) density by:

$$p_o(x)[n_o(x)] \equiv \frac{n_{in(ip)}^2}{N_{d(a)}^*(x, r_{d(a)})}, \quad (21)$$

and a normalized excess minority-h(e) density $u(x)$ or a relative deviation between $p(x)[n(x)]$ and $p_o(x)[n_o(x)]$.

$$u(x) \equiv \frac{p(x)[n(x)] - p_o(x)[n_o(x)]}{p_o(x)[n_o(x)]}, \quad (22)$$

which must verify the two following boundary conditions as:

$$u(x = 0) \equiv \frac{-J_h(x=0)[J_e(x=0)]}{eS \times p_o(x=0)[n_o(x=0)]},$$

$$u(x = W) = \exp\left(\frac{V}{n_{I(II)}(V) \times V_T}\right) - 1.$$

Here, $n_{I(II)}(V)$ is a photovoltaic conversion factor determined latter, $S \left(\frac{\text{cm}}{\text{s}}\right)$ is the surface recombination velocity at the emitter contact, V is the applied voltage, $V_T \equiv (k_B T/e)$ is the thermal voltage, and the minority-hole (electron) current density $J_{h(e)}(x, r_{d(a)})$.

Further, from the Fick's law for minority hole (electron)-diffusion equations, one has [1]:

$$J_{h(e)}(x, r_{d(a)}) = \frac{-e(+e) \times n_{in(ip)}^2}{F_{h(e)}(x)} \times \frac{du(x)}{dx} = \frac{-e(+e) n_{in(ip)}^2 D_{h(e)}(N_{d(a)}, r_{d(a)})}{N_{d(a)}^*(x, r_{d(a)})} \times \frac{du(x)}{dx}, \quad (23)$$

where $N_{d(a)}^*(x, r_{d(a)})$ is given in Eq. (17), $D_{h(e)}$ and $F_{h(e)}$ are determined respectively in Equations (12, 13, 18), and from the minority-hole (electron) continuity equation as:

$$\frac{dJ_{h(e)}(x, r_{d(a)})}{dx} = -e(+e) \times n_{in(ip)}^2 \times \frac{u(x)}{F_{h(e)}(x) \times L_{h(e)}^2(x)} = -e(+e) \times n_{in(ip)}^2 \times \frac{u(x)}{N_{d(a)}^*(x, r_{d(a)}) \times \tau_{hE(eE)}}, \quad (24)$$

Therefore, the following second-order differential equation is obtained:

$$\frac{d^2u(x)}{dx^2} - \frac{dF_{h(e)}(x)}{dx} \times \frac{du(x)}{dx} - \frac{u(x)}{L_{h(e)}^2(x)} = 0, \quad (25)$$

Then, taking into account the two above boundary conditions given in Eq. (22), one thus gets the general solution of this Eq. (25), as:

$$u(x) = \frac{\sinh(P(x)) + I(W, S) \times \cosh(P(x))}{\sinh(P(W)) + I(W, S) \times \cosh(P(W))} \times \left(\exp\left(\frac{V}{n_{I(II)}(V) \times V_T}\right) - 1 \right), \quad (26)$$

where the factor $I(W, S)$ is determined by:

$$I(W, S) = \frac{D_{h(e)}(N_{d(a)o}(W))}{S \times L_{h(e)}(N_{do(ao)}(W))}, \quad (27)$$

Further, since $\frac{dP(x)}{dx} \equiv C \times F_{h(e)}(x) = \frac{1}{L_{h(e)}(x)}$, $C = 2.0893 \times 10^{-30}$ (cm⁴/s), for the X-crystal, being an empirical parameter, chosen for each crystalline semiconductor, $P(x)$ is thus found to be defined by:

$$P(x) \equiv \int_0^x \frac{dx}{L_{h(e)}(x)}, \quad 0 \leq x \leq W, \quad P(x = W) \equiv \left(\frac{1}{W} \times \int_0^W \frac{dx}{L_{h(e)}(x)} \right) \times W \equiv \frac{W}{L_{h(e)}^*(x)} = \frac{L_{h(e)}}{L_{h(e)}^*(x)} \times \frac{W}{L_{h(e)}}, \quad (28)$$

where $L_{h(e)}^*(x)$ is the effective minority hole (minority electron) diffusion length. Further, the minority-hole (electron) current density injected into the HD[d(a)-X]ER is found to be given by:

$$J_{h(e)}(x, W, N_{d(a)}, r_{d(a)}, S, V) = -J_{Eno}(x, W, N_d, r_d, S) [J_{Epo}(x, W, N_a, r_a, S)] \times \left(\exp\left(\frac{V}{n_{I(II)}(V) \times V_T}\right) - 1 \right), \quad (29)$$

where $J_{Eno(Epo)}$ is the saturation minority hole (minority electron) current density,

$$J_{Eno(Epo)}(x, W, N_{d(a)}, r_{d(a)}, S) = \frac{en_{in(ip)}^2 \times D_{h(e)}}{N_{d(a)}^*(x, r_{d(a)}) \times L_{h(e)}} \times \frac{\cosh(P(x)) + I(W, S) \times \sinh(P(x))}{\sinh(P(W)) + I(W, S) \times \cosh(P(W))}. \quad (30)$$

In the following, we will denote $P(W)$ and $I(W, S)$ by P and I , for a simplicity. So, Eq. (30) gives:

$$J_{Eno(Epo)}(x = 0, W, N_{d(a)}, r_{d(a)}, S) = \frac{en_{in(ip)}^2 \times D_{h(e)}}{N_{d(a)}^*(x, r_{d(a)}) \times L_{h(e)}} \times \frac{1}{\sinh(P) + I \times \cosh(P)}, \quad (31)$$

$$J_{Eno(Epo)}(x = W, W, N_{d(a)}, r_{d(a)}, S) = \frac{en_{in(ip)}^2 \times D_{h(e)}}{N_{d(a)}^*(x=W, r_{d(a)}) \times L_{h(e)}} \times \frac{\cosh(P) + I \times \sinh(P)}{\sinh(P) + I \times \cosh(P)}, \quad (32)$$

and then,

$$\frac{J_{h(e)}(x=0, W, N_{d(a)}, r_{d(a)}, S, V)}{J_{h(e)}(x=W, W, N_{d(a)}, r_{d(a)}, S, V)} \equiv \frac{J_{Eno(Epo)}(x=0, W, N_{d(a)}, r_{d(a)}, S)}{J_{Eno(Epo)}(x=W, W, N_{d(a)}, r_{d(a)}, S)} = \frac{1}{\cosh(P) + I \times \sinh(P)}. \quad (33)$$

Now, if defining the effective excess minority-hole (electron) charge storage in the emitter region by:

$$Q_{h(e)}^*(x = W, N_{d(a)}, r_{d(a)}) \equiv \int_0^W +e(-e) \times u(x) \times p_o(x) [n_o(x)] \times \frac{\tau_{hE(eE)}(N_{d(a)}, r_{d(a)})}{\tau_{hE(eE)}(\rho_{d(a)}(x), r_{d(a)})} dx, \text{ and the effective}$$

minority hole (minority electron) transit time [htt(ett)] by: $\tau_{htt(ett)}^*(x = W, W, N_{d(a)}, r_{d(a)}, S) \equiv Q_{h(e)}^*(x = W, N_{d(a)}, r_{d(a)}) / J_{Eno(Epo)}(x = W, W, N_{d(a)}, r_{d(a)}, S)$, and from Equations (24, 31), one obtains:

$$\frac{\tau_{htt(ett)}^*(x=W, W, N_{d(a)}, r_{d(a)}, S)}{\tau_{hE(eE)}} \equiv 1 - \frac{J_{Eno(Epo)}(x=0, W, N_{d(a)}, r_{d(a)}, S)}{J_{Eno(Epo)}(x=W, W, N_{d(a)}, r_{d(a)}, S)} = 1 - \frac{1}{\cosh(P) + I \times \sinh(P)}. \quad (34)$$

Now, some important results can be obtained and discussed below.

As $P \ll 1$ (or $W \ll L_{h(e)}$) and $S \rightarrow \infty$, $I \equiv I(W, S) = \frac{D_{h(e)}(N_{do(ao)}(W))}{S \times L_{h(e)}(N_{do(ao)}(W))} \rightarrow 0$, from Eq. (34), one has:

$$\frac{\tau_{htt(ett)}^*(x=W, W, N_{d(a)}, r_{d(a)}, S)}{\tau_{hE(eE)}} \rightarrow 0, \text{ suggesting a completely transparent emitter region (CTER)-case, where, from}$$

Eq. (32), one obtains:

$$J_{Eno(Epo)}(x = W, N_{d(a)}, r_{d(a)}, S \rightarrow \infty) \rightarrow \frac{en_{in(ip)}^2 \times D_{h(e)}}{N_{d(a)}^*(x=W, r_{d(a)}) \times L_{h(e)}} \times \frac{1}{P(W)}. \quad (35)$$

Further, as $P \gg 1$ (or $W \gg L_{h(e)}$) and $S \rightarrow 0$, $I \equiv I(W, S) = \frac{D_{h(e)}(N_{do(ao)}(W))}{S \times L_{h(e)}(N_{do(ao)}(W))} \rightarrow \infty$, and from Eq. (34) one has:

$$\frac{\tau_{htt(ett)}^*(x=W, W, N_{d(a)}, r_{d(a)}, S)}{\tau_{hE(eE)}} \rightarrow 1, \text{ suggesting a completely opaque emitter region (COER)-case, where, from Eq.}$$

(32), one gets:

$$J_{Eno(Epo)}(x = W, N_{d(a)}, r_{d(a)}, S \rightarrow 0) \rightarrow \frac{en_{in(ip)}^2 \times D_{h(e)}}{N_{d(a)}^*(x=W, r_{d(a)}) \times L_{h(e)}} \times \tanh(P). \quad (36)$$

In summary, in the two $n^+(p^+) - p(n)$ X-junction solar cells, the dark carrier-minority saturation current density $J_{ol(oll)}$, defined in Eq. (10), is now rewritten as:

$$J_{ol(oll)}(W, N_{d(a)}, r_{d(a)}, S, N_{a(d)}, r_{a(d)}) \equiv J_{Eno(Epo)}(W, N_{d(a)}, r_{d(a)}, S) + J_{Bpo(Bno)}(N_{a(d)}, r_{a(d)}), \quad (37)$$

where $J_{Eno(Epo)}$ and $J_{Bpo(Bno)}$ are determined respectively in Equations (32, 11).

4. Photovoltaic conversion effect at 300K

Here, in the $n^+(p^+) - p(n)$ X-junction solar cells at $T=300$ K, denoted respectively by I(II), and for physical conditions, respectively, as:

$$W = 50 \text{ (300)} \mu\text{m}, N_{d \equiv \text{Ge}(a \equiv \text{Ge})} = 10^{20} (10^{20}) \text{ cm}^{-3}, r_{do(ao)}, S = 100 \text{ (100)} \left(\frac{\text{cm}}{\text{s}}\right); N_{a \equiv \text{Ge}(d \equiv \text{Ge})} = 10^{17} (10^{17}) \text{ cm}^{-3}, r_{ao(do)}, \text{ for } X \equiv \text{Ge} \quad (38.1)$$

$$W = 0.1 \text{ (0.1)} \mu\text{m}, N_{d \equiv \text{Sb}(a \equiv \text{Ga})} = 10^{19} (10^{20}) \text{ cm}^{-3}, r_{do(ao)}, S = 100 \text{ (100)} \left(\frac{\text{cm}}{\text{s}}\right); N_{a \equiv \text{Ga}(d \equiv \text{Sb})} = 10^{17} (10^{17}) \text{ cm}^{-3}, r_{ao(do)}, \text{ for } X \equiv \text{GaSb}, \quad (38.2)$$

$$W = 0.1 \text{ (0.1)} \mu\text{m}, N_{d \equiv \text{Te}(a \equiv \text{Cd})} = 10^{19} (10^{20}) \text{ cm}^{-3}, r_{do(ao)}, S = 100 \text{ (100)} \left(\frac{\text{cm}}{\text{s}}\right); N_{a \equiv \text{Cd}(d \equiv \text{Te})} = 10^{17} (10^{17}) \text{ cm}^{-3}, r_{ao(do)}, \text{ for } X \equiv \text{CdTe}, \text{ and} \quad (38.3)$$

$$W = 0.1 \text{ (0.1)} \mu\text{m}, N_{d \equiv \text{Te}(a \equiv \text{Cd})} = 10^{19} (10^{20}) \text{ cm}^{-3}, r_{do(ao)}, S = 100 \text{ (100)} \left(\frac{\text{cm}}{\text{s}}\right); N_{a \equiv \text{Cd}(d \equiv \text{Te})} = 10^{17} (10^{17}) \text{ cm}^{-3}, r_{ao(do)}, \text{ for } X \equiv \text{CdSe}, \quad (38.4)$$

we propose, at given open circuit voltages: $V_{ocI1(ocI2)}$ and $V_{ocII1(ocII2)}$, the corresponding data of the short circuit current density $J_{scI(II)}$, in order to formulate our following treatment method of two fixe points as [1]:

for $X \equiv \text{Ge}$ and at: $V_{ocI1(ocII1)} = 0.221 \text{ (0.248)} \text{ V}$ and $V_{ocI2(ocII2)} = 0.283 \text{ (0.283)} \text{ V}$,

$$J_{scI1(scII1)} = 0.0481 \text{ (0.0466)} \text{ (A/cm}^2\text{)} \text{ and } J_{scI2(scII2)} = 0.06103 \text{ (0.06103)} \text{ (A/cm}^2\text{)}, \quad (39.1)$$

for $X \equiv \text{GaSb}$ and at: $V_{ocI1(ocI2)} = V_{ocII1(ocII2)} = 0.312 \text{ (0.374)} \text{ V}$,

$$J_{scI1(scI2)} = J_{scII1(scII2)} = 0.0388 (0.03909) \text{ (A/cm}^2\text{)} \quad , \quad (39.2)$$

for $X \equiv \text{CdTe}$ and at: $V_{ocI1(ocI2)} = V_{ocII1(ocII2)} = 0.73 (0.8759) \text{ V}$,

$$J_{scI1(scI2)} = J_{scII1(scII2)} = 0.0216 (0.03025) \text{ (A/cm}^2\text{)} \quad , \quad \text{and} \quad (39.3)$$

for $X \equiv \text{CdSe}$ and at: $V_{ocI1(ocI2)} = V_{ocII1(ocII2)} = 0.87 (1.03) \text{ V}$,

$$J_{scI1(scI2)} = J_{scII1(scII2)} = 0.02432 (0.0202) \text{ (A/cm}^2\text{)} \quad . \quad (39.4)$$

Now, we define the net current density J at $T=300 \text{ K}$, obtained for the infinite shunt resistance, and expressed as a function of the applied voltage V , flowing through the $n^+(p^+) - p(n)$ X-junction of solar cells, as [1]:

$$J(V) \equiv J_{ph.}(V) - J_{ol(olI)} \times (e^{X_{I(II)}(V)} - 1), \quad X_{I(II)}(V) \equiv \frac{V}{n_{I(II)}(V) \times V_T}, \quad V_T \equiv \frac{k_B T}{e} = 0.02585 \text{ V}, \quad (40)$$

where the function $n_{I(II)}(V)$ is the photovoltaic conversion factor (PVCF), noting that as $V = V_{oc}$, being the open circuit voltage, $J(V) = 0$, the photocurrent density is defined by: $J_{ph.}(V = V_{oc}) \equiv J_{scI(scII)}(W, N_{d(a)}, r_{d(a)}, S, N_{a(d)}, r_{a(d)}, V_{oc})$, for $V_{oc} \geq V_{ocI1(ocII1)}$.

Therefore, the photovoltaic conversion effect occurs, according to:

$$J_{scI(scII)}(W, N_{d(a)}, r_{d(a)}, S, N_{a(d)}, r_{a(d)}, V_{oc}) \equiv J_{ol(olI)}(W, N_{d(a)}, r_{d(a)}, S, N_{a(d)}, r_{a(d)}) \times (e^{X_{I(II)}(V_{oc})} - 1), \quad (41)$$

where $n_{I(II)}(V_{oc}) \equiv n_{I(II)}(W, N_{d(a)}, r_{d(a)}, S, N_{a(d)}, r_{a(d)}, V_{oc})$, and $X_{I(II)}(V_{oc}) \equiv \frac{V_{oc}}{n_{I(II)}(V_{oc}) \times V_T}$.

Here, one remarks that (i) for a given V_{oc} , both $n_{I(II)}$ and $J_{ol(olI)}$ have the same variations, obtained in the same physical conditions, as observed in many cases, and (ii) the function $(e^{X_{I(II)}(V_{oc})} - 1)$ or the PVCF, $n_{I(II)}$, representing the photovoltaic conversion effect, tconverts the light, represented by $J_{scI(scII)}$, into the electricity, by $J_{ol(olI)}$.

Then, from Eq. (41), for $n^+(p^+) - p(n)$ X-junction solar cells, one respectively obtained: for $X \equiv \text{Ge}$,

$$n_{I1(I2)}(V_{ocI1(ocI2)}, J_{scI1(scI2)}) = 0.1.0834 (1.3467) \text{ and } n_{II1(II2)}(V_{ocII1(ocII2)}, J_{scII1(scII2)}) = 1.08108 (1.19726),$$

for $X \equiv \text{GaSb}$,

$$n_{I1(I2)}(V_{ocI1(ocI2)}, J_{scI1(scI2)}) = 0.8818 (1.0564) \text{ and } n_{II1(II2)}(V_{ocII1(ocII2)}, J_{scII1(scII2)}) = 0.82624 (0.98992),$$

for $X \equiv \text{CdTe}$,

$$n_{I1(I2)}(V_{ocI1(ocI2)}, J_{scI1(scI2)}) = 0.6846 (0.8147) \text{ and } n_{II1(II2)}(V_{ocII1(ocII2)}, J_{scII1(scII2)}) = 0.70157 (0.8348), \text{ and}$$

for $X \equiv \text{CdSe}$,

$$n_{I1(I2)}(V_{ocI1(ocI2)}, J_{scI1(scI2)}) = 0.6656 (0.7910) \text{ and } n_{II1(II2)}(V_{ocII1(ocII2)}, J_{scII1(scII2)}) = 0.6618 (0.7864).$$

Now, for $V_{oc} \geq V_{ocI1(ocII1)}$ and $X \equiv (\text{Ge, GaSb, CdTe, or CdSe})$, respectively, one can propose the general expressions for the PVCF, in order to get exactly the above obtained values of $n_{I1(I2)}$ and $n_{II1(II2)}$,

$$n_{I(II)}(W, N_{d(a)}, r_{d(a)}, S, N_{a(d)}, r_{a(d)}, V_{oc}) = n_{I1(II1)} + n_{I2(II2)} \times \left(\frac{V_{oc}}{V_{ocI1(ocII1)}} - 1 \right)^{\alpha(\beta)}, \quad (42)$$

where $\alpha(\beta) = 1.2841 (1.19131), 1.114 (1.11374), 1.139 (1.13972), 1.0878 (1.0881)$.

Therefore, one can determine the general expressions for the fill factors, as:

$$F_{I(II)}(W, N_{d(a)}, r_{d(a)}, S, N_{a(d)}, r_{a(d)}, V) = \frac{X_{I(II)}(V_{oc}) - \ln[X_{I(II)}(V_{oc}) + b]}{X_{I(II)}(V_{oc}) + a}, \quad a, b \geq 0, \quad (43)$$

where a and b will be chosen here, as: $a=1$, $b=0.72$, corresponding to the ideal X-junction solar cells [2, 4], and $a=b=0$, according to limiting highest values of $F_{I(II)}$.

Finally, the efficiency $\eta_{I(II)}$ can be defined in the $n^+(p^+) - p(n)$ junction solar cells, by:

$$\eta_{I(II)}(W, N_{d(a)}, r_{d(a)}, S, N_{a(d)}, r_{a(d)}, V_{oc}) \equiv \frac{J_{scI(scII)} \times V_{oc} \times F_{I(II)}}{P_{in}}, \quad (44)$$

being assumed to be obtained at 1 sun illumination or at AM1.5G spectrum ($P_{in} = 0.100 \frac{W}{cm^2}$).

5. Numerical Results and Concluding Remarks

We will respectively consider the two following cases:

HD [P(B); As (Ga); Sb(Mg); Sn(In)] X – ER – LD [B (P); Ga (As); Mg (Sb); In (Sn)] X – BR – cases, noting that, for each X-crystal, one has: 4 (n^+p) – junctions: (P^+B , As^+Ga , Sb^+Mg , Sn^+In), and 4 (p^+n) – junctions: (B^+P , Ga^+As , Mg^+Sb , In^+Sn). Then, one proposes the physical conditions for the determination of various photovoltaic conversion coefficients, as:

$$W = 0.2 \text{ (300) } \mu m, \quad N_{d(a)} = 10^{20} \text{ (10}^{20}\text{) } cm^{-3}, \quad S = 100 \text{ (100) } (cm/s); \quad N_{a(d)} = 10^{17} \text{ (10}^{17}\text{) } cm^{-3}, \quad \text{for } X \equiv Ge, \quad (45.1)$$

$$W = 0.1 \text{ (0.1) } \mu m, \quad N_{d(a)} = 10^{19} \text{ (10}^{20}\text{) } cm^{-3}, \quad S = 100 \text{ (100) } (cm/s); \quad N_{a(d)} = 10^{17} \text{ (10}^{17}\text{) } cm^{-3}, \quad \text{and finally, for } X \equiv GaSb, \quad (45.2)$$

$$W = 0.1 \text{ (0.1) } \mu m, \quad N_{d(a)} = 10^{19} \text{ (10}^{20}\text{) } cm^{-3}, \quad S = 100 \text{ (100) } (cm/s); \quad N_{a(d)} = 10^{17} \text{ (10}^{17}\text{) } cm^{-3}, \quad \text{for } X \equiv CdTe, \text{ and finally,} \quad (45.3)$$

$$W = 0.1 \text{ (0.1) } \mu m, \quad N_{d(a)} = 10^{19} \text{ (10}^{20}\text{) } cm^{-3}, \quad S = 100 \text{ (100) } (cm/s); \quad N_{a(d)} = 10^{17} \text{ (10}^{17}\text{) } cm^{-3}, \quad \text{for } X \equiv CdSe. \quad (45.4)$$

5.1. $n^+(p^+) - p(n)$ Ge-Junction Solar Cells

First HD [P; As; Sb; Sn] Ge – ER – LD [B; Ga; Mg; In] Ge – BR – case

Here, there are the 4 (n^+p) – Ge junctions, being denoted by: (P^+B , As^+Ga , Sb^+Mg , Sn^+In).

Then, from the physical conditions given in Eq. (45.1), one respectively gets: from Eq. (34), $\frac{\tau_{ht}^*}{\tau_{hE}} = (0, 0, 0, 0)$, suggesting a completely transparent condition, from Eq. (32), $J_{Eno} = (2.18, 2.19, 2.19, 2.19) \times 10^{-8} \left(\frac{A}{cm^2} \right)$, from Eq. (11), $J_{Bpo} = (4.26, 1.78, 1.43, 1.28) \times 10^{-5} \left(\frac{A}{cm^2} \right)$, and finally from Eq. (37), $J_{ol} = (4.26, 1.78, 1.44, 1.28) \times 10^{-5} \left(\frac{A}{cm^2} \right) \simeq J_{Bpo}$, which decreases with an increasing r_a , due to the increase in the intrinsic band gap (IBG), as observed in Table 1.1.

Table 2.1. In the HD[(P; As; Sb; Sn)-Ge] ER-LD[(B; Ga; Mg; In)-Ge] BR and for physical conditions given in Eq. (45.1), our numerical results of η_I , J_{scI} , F_I , and η_{II} , are computed, Equations (42, 41, 43, 44), respectively. Here, on

notes that, for a given V_{oc} and with increasing $r_{d(a)}$, the function n_I decreases, while other functions J_{scI} , F_I , and η_I increase, being due to the $r_{d(a)}$ -effect, suggesting thus the new obtained results.

$V_{oc}(V)$	n_I	$J_{scI}(\frac{mA}{cm^2})$	$F_I(\%)$	$\eta_I(\%)$
In Eq. (43), obtained for the F as a=1 and b=0.72, according to an ideal solar cells (Green, 1981).				
n^+p	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In
0.221	1.216; 1.082; 1.053; 1.039	48.10; 48.10; 48.10; 48.10	62.04; 64.56; 65.13; 65.42	6.595; 6.863; 6.923; 6.954
0.27	1.434; 1.276; 1.243; 1.226	62.06; 63.76; 64.18; 64.41	62.82; 65.30; 65.86; 66.14	10.53; 11.24; 11.41; 11.50
0.28	1.492; 1.328; 1.294; 1.276	60.41; 61.79; 62.14; 62.32	62.74; 65.22; 65.78; 66.06	10.61; 11.28; 11.44; 11.53
0.283	1.510; 1.345; 1.309; 1.292	59.78; 61.05; 61.37; 61.54	62.71; 65.19; 65.74; 66.03	10.61; 11.26; 11.42; 11.50
0.29	1.554; 1.383; 1.347; 1.329	58.13; 59.12; 59.37; 59.50	62.62; 65.11; 65.66; 65.95	10.56; 11.16; 11.30; 11.38
1.00	8.810; 7.862; 7.659; 7.557	3.395; 2.422; 2.228; 2.132	51.19; 53.88; 54.50; 54.81	1.738; 1.305; 1.214; 1.169
In Eq. (43), obtained for F as a=b=0, according to highest values of F.				
n^+p	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In
0.221	1.216; 1.082; 1.053; 1.039	48.10; 48.10; 48.10; 48.10	72.26; 73.84; 74.20; 74.39	7.681; 7.849; 7.888; 7.907
0.27	1.434; 1.276; 1.243; 1.226	62.06; 63.76; 64.18; 64.41	72.74; 74.31; 74.67; 74.85	12.19; 12.79; 12.94; 13.01
0.28	1.492; 1.328; 1.294; 1.276	60.41; 61.79; 62.14; 62.32	72.69; 74.26; 74.62; 74.80	12.29; 12.85; 12.98; 13.05
0.283	1.510; 1.345; 1.309; 1.292	59.78; 61.05; 61.37; 61.54	72.67; 74.24; 74.60; 74.78	12.29; 12.83; 12.96; 13.02
0.29	1.554; 1.383; 1.347; 1.329	58.13; 59.12; 59.37; 59.50	72.62; 74.19; 74.54; 74.73	12.24; 12.72; 12.83; 12.89
1.00	8.810; 7.862; 7.659; 7.557	3.395; 2.422; 2.228; 2.132	66.30; 67.61; 67.93; 68.10	2.251; 1.637; 1.513; 1.452

Second HD [B ; Ga ; Mg ; In] Ge – ER – LD [P; As ; Sb; Sn] Ge – BR –case

Here, there are 4 (p^+n) – Ge junctions: (B^+P , Ga^+As , Mg^+Sb , In^+Sn).

Then, from the physical conditions given in Eq. (45.1), one respectively obtains: from Eq. (34), $\frac{\tau_{ett}^*}{\tau_{eE}} = (0, 0, 0, 0)$ suggesting a completely transparent condition, from Eq. (32), $J_{Epo} = (1.73, 1.11, 1.00, 0.95) \times 10^{-8} \left(\frac{A}{cm^2}\right)$, from Eq. (11), $J_{Bno} = (6.94, 6.58, 5.96, 5.61) \times 10^{-6} \left(\frac{A}{cm^2}\right)$, and finally from Eq. (37), $J_{oII} = (6.96, 6.59, 5.97, 5.62) \times 10^{-6} \left(\frac{A}{cm^2}\right) \simeq J_{Bno}$, which decreases with an increasing r_d , due to the increase in the IBG, as observed in Table 1.1.

Table 2.2. In the HD[(B; Ga; Mg; In)-Ge] ER-LD[(P; As; Sb; Sn)-Ge] BR and for physical conditions given in Eq. (45.1), our numerical results of n_{II} , J_{scII} , F_{II} , and η_{II} , are computed, using Equations (42, 41, 43, 44), respectively.

Here, on notes that, for a given V_{oc} and with increasing $r_{a(d)}$, the function n_{II} decreases, while other functions J_{scII} , F_{II} , and η_{II} increase, being due to the $r_{a(d)}$ -effect, suggesting thus the new obtained results.

$V_{oc}(V)$	n_{II}	$J_{scII}(\frac{mA}{cm^2})$	$F_{II}(\%)$	$\eta_{II}(\%)$
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In Eq. (43), obtained for the F as a=1 and b=0.72, according to an ideal solar cells (Green, 1981).

p ⁺ n	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn
0.248	1.089; 1.082; 1.070; 1.063	46.60; 46.60; 46.60; 46.60	66.82; 66.95; 67.17; 67.31	7.723; 7.737; 7.763; 7.779
0.283	1.206; 1.198; 1.185; 1.177	60.92; 61.01; 61.18; 61.28	67.43; 67.55; 67.78; 67.91	11.63; 11.66; 11.73; 11.79
0.32	1.365; 1.357; 1.342; 1.333	60.27; 60.34; 60.48; 60.56	67.41; 67.53; 67.75; 67.88	13.00; 13.04; 13.11; 13.16
0.33	1.411; 1.403; 1.387; 1.378	58.87; 58.94; 59.05; 59.12	67.35; 67.48; 67.70; 67.83	13.09; 13.12; 13.19; 13.23
0.34	1.459; 1.450; 1.434; 1.424	57.21; 57.26; 57.35; 57.40	67.29; 67.41; 67.63; 67.77	13.09; 13.12; 13.19; 13.22
1.00	5.609; 5.575; 5.515; 5.479	6.870; 6.782; 6.627; 6.534	61.62; 61.75; 61.99; 62.13	4.234; 4.188; 4.108; 4.060

In Eq. (43), obtained for F as a=b=0, according to highest values of F.

p ⁺ n	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn
0.248	1.089; 1.082; 1.070; 1.063	46.60; 46.60; 46.60; 46.60	75.30; 75.38; 75.53; 75.62	8.702; 8.712; 8.729; 8.739
0.283	1.206; 1.198; 1.185; 1.177	60.92; 61.01; 61.18; 61.28	75.70; 75.78; 75.93; 76.02	13.05; 13.08; 13.15; 13.18
0.32	1.365; 1.357; 1.342; 1.333	60.27; 60.34; 60.48; 60.56	75.68; 75.77; 75.91; 76.00	14.60; 14.63; 14.69; 14.73
0.33	1.411; 1.403; 1.387; 1.378	58.87; 58.94; 59.05; 59.12	75.65; 75.73; 75.88; 75.96	14.70; 14.73; 14.79; 14.82
0.34	1.459; 1.450; 1.434; 1.424	57.21; 57.26; 57.35; 57.40	75.61; 75.69; 75.83; 75.92	14.70; 14.73; 14.79; 14.82
1.00	5.609; 5.575; 5.515; 5.479	6.870; 6.782; 6.627; 6.534	72.00; 72.08; 72.23; 72.31	4.946; 4.888; 4.786; 4.725

5.2. n⁺ (p⁺) – p (n) GaSb-Junction Solar Cells

First HD [P; As; Sb; Sn] GaSb – ER – LD [B; Ga; Mg; In] GaSb – BR –case

Here, there are the 4 (n⁺p) – GaSb junctions, being denoted by: (P⁺B, As⁺Ga, Sb⁺Mg, Sn⁺In).

Then, from the physical conditions given in Eq. (45.2), one respectively gets: from Eq. (34),

$\frac{\tau_{htt}^*}{\tau_{hE}} = (0, 0, 0, 0)$, suggesting a completely transparent condition, from Eq. (32), $J_{Eno} = (9.30, 9.07, 8.92, 8.91) \times 10^{-12} \left(\frac{A}{cm^2}\right)$, from Eq. (11), $J_{Bpo} = (1.29, 0.44, 0.39, 0.35) \times 10^{-7} \left(\frac{A}{cm^2}\right)$, and finally from Eq. (37), $J_{ol} = (1.29, 0.44, 0.39, 0.35) \times 10^{-7} \left(\frac{A}{cm^2}\right) \simeq J_{Bpo}$, which decreases with an increasing r_a , due to the increase in the IBG, as observed in Table 1.2.

Table 3.1. In the HD[(P; As; Sb; Sn)-GaSb] ER-LD[(B; Ga; Mg; In)-GaSb] BR and for physical conditions given in Eq. (45.2), our numerical results of n_I , J_{scI} , F_I , and η_I , are computed, using Equations (42, 41, 43, 44), respectively. Here, on notes that, for a given V_{oc} and with increasing $r_{d(a)}$, the function n_I decreases, while other functions J_{scI} , F_I , and η_I increase, being due to the impurity size $r_{d(a)}$ -effect, suggesting thus the new obtained results.

$V_{oc}(V)$	n_I	$J_{scI}(\frac{mA}{cm^2})$	$F_I(\%)$	$\eta_I(\%)$
In Eq. (43), obtained for F, a=1, b=0.72, according to an ideal solar cells (Green, 1981).				
n ⁺ p	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In
0.312	0.957; 0.882; 0.873; 0.868	38.80; 38.80; 38.80; 38.80	73.62; 75.02; 75.18; 75.29	8.913; 9.082; 9.102; 9.114
0.35	1.067; 0.983; 0.974; 0.968	42.01; 42.29; 42.32; 42.34	73.73; 75.13; 75.29; 75.39	10.84; 11.12; 11.15; 11.17

0.36	1.099; 1.013; 1.003; 0.997	40.97; 41.15; 41.18; 41.19	73.70; 75.10; 75.26; 75.36	10.87; 11.13; 11.16; 11.17
0.37	1.133; 1.044; 1.034; 1.028	39.66; 39.73; 39.74; 39.74	73.65; 75.05; 75.21; 75.32	10.81; 11.03; 11.06; 11.08
0.374	1.146; 1.056; 1.046; 1.040	39.09; 39.11; 39.11; 39.11	73.63; 75.03; 75.19; 75.30	10.76; 10.97; 11.00; 11.01
1.00	3.723; 3.431; 3.399; 3.378	4.201; 3.475; 3.396; 3.345	70.08; 71.61; 71.78; 71.90	2.944; 2.489; 2.438; 2.405

In Eq. (43), obtained for F, a=b=0, according to highest values of F.

n ⁺ p	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In	P ⁺ B; As ⁺ Ga; Sb ⁺ Mg; Sn ⁺ In
0.312	0.957; 0.882; 0.873; 0.868	38.80; 38.80; 38.80; 38.80	79.90; 80.88; 80.99; 81.07	9.673; 9.791; 9.805; 9.814
0.35	1.067; 0.983; 0.974; 0.968	42.01; 42.29; 42.32; 42.34	79.98; 80.96; 81.07; 81.14	11.76; 11.98; 12.01; 12.02
0.36	1.099; 1.013; 1.003; 0.997	40.97; 41.15; 41.18; 41.19	79.95; 80.93; 81.04; 81.12	11.79; 11.99; 12.01; 12.03
0.37	1.133; 1.044; 1.034; 1.028	39.66; 39.73; 39.74; 39.74	79.92; 80.90; 81.01; 81.09	11.73; 11.89; 11.91; 11.92
0.374	1.146; 1.056; 1.046; 1.040	39.09; 39.11; 39.11; 39.11	79.91; 80.89; 81.00; 81.07	11.68; 11.83; 11.85; 11.86
1.00	3.723; 3.431; 3.399; 3.378	4.201; 3.475; 3.396; 3.345	77.47; 78.51; 78.63; 78.71	3.255; 2.729; 2.670; 2.633

Second HD [B ; Ga ; Mg ; In] GaSb – ER – LD [P; As ; Sb; Sn] GaSb – BR –case

Here, there are 4 (p⁺n) – GaSb junctions: (B⁺P, Ga⁺As, Mg⁺Sb, In⁺Sn).

Then, from the physical conditions given in Eq. (45.2), one respectively obtains: from Eq. (34), $\frac{\tau_{ett}^*}{\tau_{eE}} = (0, 0, 0, 0)$ suggesting a completely transparent condition, from Eq. (32), $J_{Epo} = (2.81, 1.62, 1.52, 1.47) \times 10^{-9} \left(\frac{A}{cm^2} \right)$, from Eq. (11), $J_{Bno} = (1.97, 1.76, 1.60, 1.59) \times 10^{-8} \left(\frac{A}{cm^2} \right)$, and finally from Eq. (37), $J_{oII} = (2.25, 1.92, 1.75, 1.74) \times 10^{-8} \left(\frac{A}{cm^2} \right) \simeq J_{Bno}$, which decreases with an increasing r_d , due to the increase in the IBG, as observed in Table 1.2.

Table 3.2. In the HD[(B; Ga; Mg; In)-GaSb] ER-LD[(P; As; Sb; Sn)-GaSb] BR and for physical conditions given in Eq. (45.2), our numerical results of n_{II} , J_{scII} , F_{II} , and η_{II} , are computed, using Equations (42, 41, 43, 44), respectively. Here, on notes that, for a given V_{oc} and with increasing $r_{a(d)}$, the function n_{II} decreases, while other functions J_{scII} , F_{II} , and η_{II} increase, being due to the impurity size $r_{a(d)}$ -effect, suggesting thus the new obtained results.

$V_{oc}(V)$	n_{II}	$J_{scII} \left(\frac{mA}{cm^2} \right)$	$F_{II}(\%)$	$\eta_{II}(\%)$
In Eq. (43), obtained for F, a=1, b=0.72, according to an ideal solar cells (Green, 1981).				
p ⁺ n	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn
0.312	0.840; 0.831; 0.826; 0.825	38.80; 38.80; 38.80; 38.80	75.82; 76.00; 76.11; 76.11	9.179; 9.201; 9.213; 9.214
0.35	0.937; 0.927; 0.921; 0.920	42.43; 42.47; 42.50; 42.50	75.93; 76.10; 76.21; 76.22	11.28; 11.31; 11.33; 11.33
0.355	0.951; 0.941; 0.935; 0.934	41.88; 41.91; 41.93; 41.94	75.91; 76.09; 76.19; 76.20	11.29; 11.32; 11.34; 11.34
0.36	0.965; 0.955; 0.949; 0.948	41.23; 41.26; 41.28; 41.28	75.89; 76.07; 76.17; 76.18	11.27; 11.30; 11.32; 11.32
0.374	1.007; 0.996; 0.989; 0.989	39.08; 39.08; 39.09; 39.09	75.83; 76.01; 76.11; 76.12	11.08; 11.11; 11.17; 11.13
1.00	3.269; 3.234; 3.213; 3.212	3.090; 3.005; 2.957; 2.953	72.49; 72.69; 72.80; 72.81	2.240; 2.184; 2.152; 2.150

In Eq. (43), obtained for F, a=b=0, according to highest values of F.

p ⁺ n	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn	B ⁺ P; Ga ⁺ As; Mg ⁺ Sb; In ⁺ Sn
0.312	0.840; 0.831; 0.826; 0.825	38.80; 38.80; 38.80; 38.80	81.44; 81.57; 81.64; 81.65	9.859; 9.875; 9.884; 9.884
0.35	0.937; 0.927; 0.921; 0.920	42.43; 42.47; 42.50; 42.50	81.51; 81.64; 81.72; 81.72	12.11; 12.14; 12.15; 12.16
0.355	0.951; 0.941; 0.935; 0.934	41.88; 41.91; 41.93; 41.94	81.51; 81.63; 81.71; 81.71	12.12; 12.15; 12.16; 12.16
0.36	0.965; 0.955; 0.949; 0.948	41.23; 41.26; 41.28; 41.28	81.49; 81.62; 81.69; 81.70	12.10; 12.12; 12.14; 12.14
0.374	1.007; 0.996; 0.989; 0.989	39.08; 39.08; 39.09; 39.09	81.45; 81.58; 81.65; 81.66	11.90; 11.92; 11.94; 11.94
1.00	3.269; 3.234; 3.213; 3.212	3.090; 3.005; 2.957; 2.953	79.11; 79.25; 79.33; 79.34	2.445; 2.381; 2.346; 2.343

5.3. n⁺ (p⁺) – p (n) CdTe-Junction Solar Cells

First HD [As; Te ; Sb; Sn] CdTe – ER – LD [Ga ; Mg ; In ; Cd] CdTe – BR –case

Here, there are the 4 (n⁺p) – CdTe junctions, being denoted by: (As⁺Ga, Te⁺Mg, Sb⁺In, Sn⁺Cd).

Then, from the physical conditions given in Eq. (45.3), one respectively gets: from Eq. (34), $\frac{\tau_{ht}^*}{\tau_{hE}} = (0, 0, 0, 0)$, suggesting a completely transparent condition, from Eq. (32), $J_{Eno} = (2.24, 2.21, 2.20, 2.19) \times 10^{-23} \left(\frac{A}{cm^2}\right)$, from Eq. (11), $J_{Bpo} = (6.19, 2.97, 2.72, 2.64) \times 10^{-20} \left(\frac{A}{cm^2}\right)$, and finally from Eq. (37), $J_{ol} = (6.19, 2.97, 2.72, 2.64) \times 10^{-20} \left(\frac{A}{cm^2}\right) \simeq J_{Bpo}$, which decreases with an increasing r_a , due to the increase in the IBG, as observed in Table 1.3.

Table 4.1. In the HD[(As; Te; Sb; Sn)- CdTe] ER-LD[(Ga; Mg; In; Cd)- CdTe] BR and for physical conditions given in Eq. (45.3), our numerical results of n_l , J_{scl} , F_l , and η_l , are computed, using Equations (42, 41, 43, 44), respectively. Here, on notes that, for a given V_{oc} and with increasing $r_{d(a)}$, the function n_l decreases, while other functions J_{scl} , F_l , and η_l increase, being due to the $r_{d(a)}$ -effect, suggesting thus the new obtained results.

$V_{oc}(V)$	n_l	$J_{scl}\left(\frac{mA}{cm^2}\right)$	$F_l(\%)$	$\eta_l(\%)$
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In Eq. (43), obtained for the F as a=1 and b=0.72, according to an ideal solar cells (Green, 1981).

n ⁺ p	As ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd	As ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd	As ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd	As ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd
0.73	0.699; 0.686; 0.685; 0.685	21.60; 21.60; 21.60; 21.60	88.61; 88.76; 88.78; 88.79	13.97; 14.00; 14.00; 14.00
0.81	0.766; 0.752; 0.751; 0.750	35.77; 36.08; 36.12; 36.13	88.71; 88.87; 88.89; 88.89	25.71; 25.97; 26.01; 26.02
0.82	0.776; 0.762; 0.760; 0.760	35.46; 35.76; 35.80; 35.81	88.71; 88.87; 88.88; 88.89	25.79; 26.06; 26.09; 26.10
0.83	0.785; 0.771; 0.770; 0.769	34.88; 35.17; 35.20; 35.21	88.71; 88.86; 88.88; 88.89	25.68; 25.94; 25.97; 25.98
0.8759	0.832; 0.817; 0.815; 0.815	30.05; 30.20; 30.22; 30.23	88.68; 88.83; 88.85; 88.86	23.34; 23.50; 23.52; 23.52
1.2	1.203; 1.181; 1.179; 1.178	3.559; 3.436; 3.422; 3.417	88.20; 88.36; 88.38; 88.39	3.767; 3.643; 3.629; 3.624

In Eq. (43), obtained for F as a=b=0, according to highest values of F.

n ⁺ p	As ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd	As ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd	As ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd	As ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd
0.73	0.699; 0.686; 0.685; 0.685	21.60; 21.60; 21.60; 21.60	90.84; 90.96; 90.98; 90.98	14.32; 14.34; 14.34; 14.35
0.81	0.766; 0.752; 0.751; 0.750	35.77; 36.08; 36.12; 36.13	90.93; 91.04; 91.06; 91.06	26.35; 26.61; 26.64; 26.65
0.82	0.776; 0.762; 0.760; 0.760	35.46; 35.76; 35.80; 35.81	90.92; 91.04; 91.06; 91.06	26.44; 26.70; 26.73; 26.74

0.83	0.785; 0.771; 0.770; 0.769	34.88; 35.17; 35.20; 35.21	90.92; 91.04; 91.05; 91.06	26.32; 26.57; 26.60; 26.61
0.8759	0.832; 0.817; 0.815; 0.815	30.05; 30.20; 30.22; 30.23	90.90; 91.02; 91.03; 91.03	23.93; 24.08; 24.10; 24.10
1.2	1.203; 1.181; 1.179; 1.178	3.559; 3.436; 3.422; 3.417	90.53; 90.66; 90.67; 90.68	3.867; 3.738; 3.723; 3.718

Second HD [Ga ; Mg ; In ; Cd] CdTe – ER – LD [As; Te ; Sb; Sn] CdTe – BR –case

Here, there are 4 (p^+n) – CdTe junctions: (Ga^+As , Mg^+Te , In^+Sb , Cd^+Sn).

Then, from the physical conditions given in Eq. (45.3), one respectively obtains: from Eq. (34), $\frac{\tau_{ett}^*}{\tau_{eE}} = (0, 0, 0, 0)$ suggesting a completely transparent condition, from Eq. (32), $J_{Epo} = (1.33, 0.69, 0.64, 0.62) \times 10^{-19} \left(\frac{A}{cm^2}\right)$, from Eq. (11), $J_{Bno} = (1.05, 0.95, 0.94, 0.92) \times 10^{-20} \left(\frac{A}{cm^2}\right)$, and finally from Eq. (37), $J_{oII} = (1.44, 0.79, 0.73, 0.71) \times 10^{-19} \left(\frac{A}{cm^2}\right) \simeq J_{Epo}$, which decreases with an increasing r_a , due to the increase in the IBG, as observed in Table 1.3.

Table 4.2. In the HD[(Ga; Mg; In; Cd)-CdTe] ER-LD[(As; Te; Sb; Sn)- CdTe] BR and for physical conditions given in Eq. (45.3), our numerical results of n_{II} , J_{scII} , F_{II} , and η_{II} , are computed, using Equations (42, 41, 43, 44), respectively. Here, on notes that, for a given V_{oc} and with increasing $r_{a(d)}$, the function n_{II} decreases, while other functions J_{scII} , F_{II} , and η_{II} increase, being due to the $r_{a(d)}$ -effect, suggesting thus the new obtained results.

$V_{oc}(V)$	n_{II}	$J_{scII}(\frac{mA}{cm^2})$	$F_{II}(\%)$	$\eta_{II}(\%)$
In Eq. (43), obtained for the F as a=1 and b=0.72, according to an ideal solar cells (Green, 1981).				
p^+n	Ga ⁺ As; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn	Ga ⁺ As; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn	Ga ⁺ As; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn	Ga ⁺ As; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn
0.73	0.714; 0.703; 0.702; 0.701	21.60; 21.60; 21.60; 21.60	88.42; 88.55; 88.57; 88.57	13.94; 13.96; 13.97; 13.97
0.81	0.782; 0.770; 0.769; 0.769	35.62; 35.88; 35.91; 35.92	88.53; 88.66; 88.68; 88.68	25.54; 25.76; 25.79; 25.80
0.82	0.792; 0.780; 0.779; 0.778	35.33; 35.58; 35.61; 35.62	88.53; 88.66; 88.68; 88.68	25.65; 25.87; 25.89; 25.90
0.83	0.802; 0.790; 0.789; 0.788	34.78; 35.02; 35.04; 35.05	88.53; 88.66; 88.67; 88.68	25.56; 25.77; 25.79; 25.80
0.8759	0.849; 0.837; 0.835; 0.835	30.10; 30.23; 30.24; 30.25	88.49; 88.63; 88.64; 88.65	23.33; 25.46; 23.48; 23.49
1.2	1.228; 1.210; 1.208; 1.207	3.725; 3.619; 3.607; 3.602	88.01; 88.15; 88.16; 88.17	3.934; 3.828; 3.816; 3.811
In Eq. (43), obtained for F as a=b=0, according to highest values of F.				
p^+n	Ga ⁺ As; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn	Ga ⁺ As; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn	Ga ⁺ As; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn	Ga ⁺ As; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn
0.73	0.714; 0.703; 0.702; 0.701	21.60; 21.60; 21.60; 21.60	90.70; 90.80; 90.81; 90.82	14.30; 14.32; 14.32; 14.32
0.81	0.782; 0.770; 0.769; 0.769	35.62; 35.88; 35.91; 35.92	90.79; 90.89; 90.90; 90.90	26.19; 26.41; 26.44; 26.45
0.82	0.792; 0.780; 0.779; 0.778	35.33; 35.58; 35.61; 35.62	90.78; 90.89; 90.90; 90.90	26.30; 26.51; 26.54; 26.55
0.83	0.802; 0.790; 0.789; 0.788	34.78; 35.02; 35.04; 35.05	90.78; 90.88; 90.89; 90.90	26.21; 26.41; 26.44; 26.45
0.8759	0.849; 0.837; 0.835; 0.835	30.10; 30.23; 30.24; 30.25	90.76; 90.86; 90.87; 90.87	23.93; 24.06; 24.07; 24.08
1.2	1.228; 1.210; 1.208; 1.207	3.725; 3.619; 3.607; 3.602	90.39; 90.49; 90.50; 90.51	4.040; 3.930; 3.917; 3.912

5.4. $n^+ (p^+) - p (n)$ CdSe-Junction Solar Cells

First HD [Se; Te; Sb; Sn] CdSe – ER – LD [Ga; Mg; In; Cd] CdSe – BR –case

Here, there are the 4 (n^+p) – CdSe -junctions, being denoted by: (Se^+Ga , Te^+Mg , Sb^+In , Sn^+Cd).

Then, from the physical conditions given in Eq. (45.4), one respectively gets: from Eq. (34), $\frac{\tau_{ht}^*}{\tau_{he}} = (0, 0, 0, 0)$, suggesting a completely transparent condition, from Eq. (32), $J_{Eno} = (2.18, 2.03, 1.94, 1.85) \times 10^{-27} \left(\frac{A}{cm^2}\right)$, from Eq. (11), $J_{Bpo} = (4.54, 2.89, 2.74, 2.69) \times 10^{-24} \left(\frac{A}{cm^2}\right)$, and finally from Eq. (37), $J_{ol} = (4.54, 2.89, 2.74, 2.69) \times 10^{-24} \left(\frac{A}{cm^2}\right) \simeq J_{Bpo}$, which decreases with an increasing r_a , due to the increase in the IBG, as observed in Table 1.4.

Table 5.1. In the HD[(Se; Te; Sb; Sn)- CdSe] ER-LD[(Ga; Mg; In; Cd)- CdSe] BR and for physical conditions given in Eq. (45.3), our numerical results of n_I , J_{scl} , F_I , and η_I , are computed, using Equations (42, 41, 43, 44), respectively. Here, on notes that, for a given V_{oc} and with increasing $r_{d(a)}$, the function n_I decreases, while other functions J_{scl} , F_I , and η_I increase, being due to the $r_{d(a)}$ -effect, suggesting thus the new obtained results.

$V_{oc}(V)$	n_I	$J_{scl}(\frac{mA}{cm^2})$	$F_I(\%)$	$\eta_I(\%)$
In Eq. (43), obtained for the F as a=1 and b=0.72, according to an ideal solar cells (Green, 1981).				
n^+p	Se ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd	Se ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd	Se ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd	Se ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd
0.87	0.673; 0.667; 0.666; 0.666	24.32; 24.32; 24.32; 24.32	90.34; 90.41; 90.42; 90.42	19.11; 19.13; 19.13; 19.13
0.88	0.679; 0.673; 0.672; 0.672	27.21; 27.24; 27.24; 27.24	90.36; 90.43; 90.44; 90.44	21.64; 21.68; 21.68; 21.68
0.89	0.686; 0.680; 0.679; 0.679	28.70; 28.74; 28.75; 28.75	90.37; 90.44; 90.44; 90.45	23.08; 23.13; 23.14; 23.14
1.03	0.799; 0.792; 0.791; 0.791	20.17; 20.14; 20.14; 20.14	90.32; 90.38; 90.39; 90.39	18.76; 18.75; 18.75; 18.75
1.1	0.861; 0.853; 0.852; 0.852	13.45; 13.38; 13.37; 13.37	90.25; 90.32; 90.33; 90.33	13.35; 13.29; 13.29; 13.29
1.2	0.951; 0.942; 0.941; 0.941	7.136; 7.061; 7.052; 7.049	90.16; 90.22; 90.23; 90.24	7.720; 7.645; 7.636; 7.633
In Eq. (43), obtained for F as a=b=0, according to highest values of F.				
n^+p	Se ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd	Se ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd	Se ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd	Se ⁺ Ga; Te ⁺ Mg; Sb ⁺ In; Sn ⁺ Cd
0.87	0.673; 0.667; 0.666; 0.666	24.32; 24.32; 24.32; 24.32	92.18; 92.23; 92.24; 92.24	19.50; 19.51; 19.52; 19.52
0.88	0.679; 0.673; 0.672; 0.672	27.21; 27.24; 27.24; 27.24	92.19; 92.24; 92.25; 92.25	22.08; 22.11; 22.11; 22.12
0.89	0.686; 0.680; 0.679; 0.679	28.70; 28.74; 28.75; 28.75	92.20; 92.25; 92.26; 92.26	23.55; 23.60; 23.60; 23.61
1.03	0.799; 0.792; 0.791; 0.791	20.17; 20.14; 20.14; 20.14	92.16; 92.21; 92.22; 92.22	19.15; 19.13; 19.13; 19.13
1.1	0.861; 0.853; 0.852; 0.852	13.45; 13.38; 13.37; 13.37	92.11; 92.16; 92.17; 92.17	13.63; 13.57; 13.56; 13.56
1.2	0.951; 0.942; 0.941; 0.941	7.136; 7.061; 7.052; 7.049	92.03; 92.09; 92.09; 92.09	7.881; 7.802; 7.793; 7.790

Second HD [Ga; Mg; In; Cd] CdSe ER – LD [Se; Te; Sb; Sn] CdSe BR –case

Here, there are 4 (p^+n) – CdSe junctions: (Ga^+Se , Mg^+Te , In^+Sb , Cd^+Sn).

Then, from the physical conditions given in Eq. (45.4), one respectively obtains: from Eq. (34), $\frac{\tau_{ett}^*}{\tau_{eE}} = (0, 0, 0, 0)$ suggesting a completely transparent condition, from Eq. (32), $J_{Epo} = (1.56, 1.09, 1.05, 1.03) \times 10^{-24} \left(\frac{A}{cm^2}\right)$, from Eq. (11), $J_{Bno} = (0.97, 0.76, 0.68, 0.59) \times 10^{-24} \left(\frac{A}{cm^2}\right)$, and finally from Eq. (37), $J_{oII} = (2.54, 1.86, 1.73, 1.62) \times 10^{-24} \left(\frac{A}{cm^2}\right) \simeq J_{Epo}$, which decreases with an increasing r_a , due to the increase in the IBG, as observed in Table 1.4.

Table 5.2. In the HD[(Ga; Mg; In; Cd)-CdSe] ER-LD[(Se; Te; Sb; Sn)- CdSe] BR and for physical conditions given in Eq. (45.3), our numerical results of n_{II} , J_{sclI} , F_{II} , and η_{II} , are computed, using Equations (42, 41, 43, 44), respectively. Here, on notes that, for a given V_{oc} and with increasing $r_{a(d)}$, the function n_{II} decreases, while other functions J_{sclI} , F_{II} , and η_{II} increase, being due to the $r_{a(d)}$ -effect, suggesting thus the new obtained results.

$V_{oc}(V)$	n_{II}	$J_{sclI}(\frac{mA}{cm^2})$	$F_{II}(\%)$	$\eta_{II}(\%)$
In Eq. (43), obtained for the F as a=1 and b=0.72, according to an ideal solar cells (Green, 1981).				
p^+n	Ga ⁺ Se; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn	Ga ⁺ Se; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn	Ga ⁺ Se; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn	Ga ⁺ Se; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn
0.87	0.665; 0.661; 0.660; 0.659	24.32; 24.32; 24.32; 24.32	90.43; 90.48; 90.49; 90.50	19.13; 19.14; 19.14; 19.15
0.88	0.671; 0.667; 0.666; 0.665	27.26; 27.28; 27.29; 27.29	90.45; 90.49; 90.50; 90.51	21.70; 21.73; 21.73; 21.74
0.89	0.678; 0.674; 0.673; 0.672	28.79; 28.82; 28.82; 28.83	90.46; 90.50; 90.51; 90.52	23.17; 23.21; 23.22; 23.23
1.03	0.790; 0.785; 0.784; 0.783	20.22; 20.20; 20.19; 20.20	90.40; 90.45; 90.46; 90.47	18.82; 18.82; 18.81; 18.81
1.1	0.851; 0.845; 0.844; 0.843	13.42; 13.37; 13.36; 13.35	90.34; 90.39; 90.40; 90.41	13.34; 13.30; 13.29; 13.28
1.2	0.940; 0.934; 0.933; 0.932	7.069; 7.017; 7.000; 6.995	90.24; 90.29; 90.30; 90.31	7.655; 7.603; 7.591; 7.581
In Eq. (43), obtained for F as a=b=0, according to highest values of F.				
p^+n	Ga ⁺ Se; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn	Ga ⁺ Se; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn	Ga ⁺ Se; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn	Ga ⁺ Se; Mg ⁺ Te; In ⁺ Sb; Cd ⁺ Sn
0.87	0.665; 0.661; 0.660; 0.659	24.32; 24.32; 24.32; 24.32	92.25; 92.28; 92.29; 92.30	19.52; 19.52; 19.53; 19.53
0.88	0.671; 0.667; 0.666; 0.665	27.26; 27.28; 27.29; 27.29	92.26; 92.29; 92.30; 92.31	22.13; 22.16; 22.16; 22.17
0.89	0.678; 0.674; 0.673; 0.672	28.79; 28.82; 28.82; 28.83	92.26; 92.30; 92.31; 92.32	23.64; 23.67; 23.68; 23.69
1.03	0.790; 0.785; 0.784; 0.783	20.22; 20.20; 20.19; 20.20	92.22; 92.26; 92.27; 92.28	19.20; 19.19; 19.19; 19.19
1.1	0.851; 0.845; 0.844; 0.843	13.42; 13.37; 13.36; 13.35	92.18; 92.21; 92.22; 92.23	13.61; 13.57; 13.56; 13.55
1.2	0.940; 0.934; 0.933; 0.932	7.069; 7.017; 7.000; 6.995	92.10; 92.14; 92.15; 92.15	7.813; 7.759; 7.746; 7.736

In summary, for a given ($X \equiv \text{Ge, GaSb, CdTe, or CdSe}$)- crystal at $T=300 \text{ K}$, one notes that, with an increasing $r_{a(d)}$:

- $J_{oI(oII)}$ decreases, due to the increase in the IBG (as observed in Tables 1-1 to 1.4),
- and then, as observed in Tables 2.1, 2.2, ..., 5.1, 5.2, for a given V_{oc} , the photovoltaic conversion factor (PVCF), $n_{I(II)}$, decreases, giving rise to the increase in $\eta_{I(II)}$, in good agreement with an important result, obtained by Shockley and Queisser [10], stating that, for $IBG < 1.6 \text{ eV}$, $\eta_{I(II)}$ increases with increasing IBG.

Finally, from the well-known Carnot's theorem, being obtained from the second principle of the thermodynamics, the maximum efficiency of a heat engine operating between hot (H) and cold (C) reservoirs is the ratio of the temperature difference between the reservoirs to the H-reservoir temperature, T_H , expressed as:

$$\eta_{\max.} = \frac{T_H - T_C}{T_H}, \quad (46)$$

suggesting that $\eta_{\max.}$ and T_H have the same variations.

Here, for example, from Tables 2.2, 3.2, 4.2, and 5.2, and for $a = b = 0$, chosen in Eq. (43) for the fill factor F , the values of $\eta_{\max.}$ are found to be given by: 14.82 %, 12.16 %, 26.55 %, and 23.69 %, obtained at $V_{oc} = 0.33$ V, 0.355 V, 0.82 V, and 0.89 V, respectively, and at $T = 300$ K $\equiv T_C$. Therefore, from Eq. (46), with $\eta_{\max.} = 14.82$ %, 12.16 %, and 26.55 %, one obtains: $T_H = 352.2$ K, 341.5 K, 408.4 K, and 393.1 K, respectively. Thus, as noted above, $\eta_{\max.}$ and T_H both increase with an increasing IBG, for each ($X \equiv$ Ge, GaSb, CdTe, or CdSe)- crystal at $T = 300$ K $\equiv T_C$.

References

- [1] H. Van Cong, K.C. Ho-Huynh Thi, C.T. Huynh-Pivet, A. Pivet & P. Damien, "30.76% (42.73%)- New Limiting Highest Efficiencies obtained in $n^+(p^+) - p(n)$ Crystalline GaAs Junction Solar Cells at 300K, Due to the Effects of Heavy (Low) Doping and Impurity Size," SCIREA J. Phys., Vol. 7, 180-199, 2022.
- [2] M.A.Green, E.D. Dunlop, J. Hohl-Ebinger, M. Yoshita, N. Kopidakis & X. Hao, "Solar cell efficiency tables (version 59), " Prog. Photovolt. Res. & Appl., vol. 30, 3-12, 2022 ; A. Rohatgi, H.C. Chou, S. Kamra & A. Bhat, "Development of high-efficiency, thin-film CdTe solar cells, "NREL/TP-451-7065. UC Category: 1263.DE94011885.
- [3] P. Singh & N.M. Ravindra, "Temperature dependence of solar cell performance-an analysis," Solar Energ. Mater. Solar Cells, vol. 101, 36-45, 2012.
- [4] Green, M. A., "Solar cell fill factors: general graph and empirical expressions., " Solid-State Electron, vol. 24, 788-789, 1981.
- [5] B. Hekmatshoar, D. Shahrjerdi, M. Hopstaken, K. Fogel & D. K. Sadana, " High-efficiency heterojunction solar cells on crystalline germanium substrates, Appl. Phys. Lett., vol. 101, 032102, 2012.
- [6] F.Z. Kharchich & A. Khamlichi, "Simulation aided design of a high efficient GaSb based single-junction solar cell, "International Review of Applied Sciences and engineering, vol. 14, 201-2011, 2023.
- [7] L.M. Pérez, A. EL Aouami, K. Feddl, V. Tasco, A.B. et al., "Parametrs optimization of intermediate band solar cells: cases of PbTe/CdTe, PbSe/ZnTe and InN/GaN quantum dots, Crystals, vol. 12, 1002, 2022 ; A.J. Strauss, "The physical properties of cadmium telluride," Revue de Physique Appliquée, vol. 12, 167-184, 1977.
- [8] C. Kittel, "Introduction to Solid State Physics, " Wiley, New York, 84-100, 1976.

- [9] S. Parola, A. Vauthelin, J. Tournet, J. Kret, J. El Hussein, F. Martinez & Y. Cuminal, "Improved efficiency of GaSb solar cell using an $\text{Al}_{0.50}\text{Ga}_{0.50}\text{As}_{0.04}\text{Sb}_{0.96}$ window layer, " Solar Energ. Mater. Solar Cells, vol. 200, 110042, 2019; O.M.T. Kate, M.D. Jong, H.T. Hintzen & E. van der Kolk, "Efficiency enhancement calculations of states-of-the-art solar cells by luminescent layers with spectral shifting, quantum cutting, and quantum tripling function, " J. Appl. Phys., vol. 114, 084502, 2013.
- [10] W. Shockley, W. & H.J. Queisser, H. J. (1961), "Detailed balance limit of efficiency of p-n junction solar cells, " J. Appl. Phys., vol. 32, 510-519, 1961.
- [11] H. Van Cong, H. (2022), "New dielectric constant, due to the impurity size effect, and determined by an effective Bohr model, affecting strongly the Mott criterion in the metal-insulator transition and the optical band gap in degenerate (Si, GaAs, InP)-semiconductors, " SCIREA J. Phys., vol. 7, 221-234, 2022.
- [12] H. Van Cong, "Effects of impurity size and heavy doping on energy-band-structure parameters of various impurity-Si systems, " Physica B, vol. 487, 90-101, 2016.
- [13] H. Van Cong, "A new solution for minority-carrier injection into the heavily doped emitter of silicon devices, " Physica Status Solidi A, vol. 171, 631-64, 1999.
- [14] H. Van Cong & G. Debiais, "Energy band structure parameters and their data, derived from the measurements of minority carrier current density in heavily doped emitters of silicon devices, " Solar Ener. Mater. and Solar Cells, vol. 45, 385-399, 1997.
- [15] H. Van Cong & G. Debiais, , "Apparent band-gap narrowing and its data derived from the measurements of minority-carrier current density in heavily doped emitters of silicon devices, " Physica Status Solidi A, vol. 155, 547-553, 1996.
- [16] H. Van Cong, "A simple accurate solution to minority electron injection in the p-type heavily doped emitter region of silicon devices, " Physica Status Solidi A, vol. 149, 619-628, 1995.
- [17] H. Van Cong & G. Debiais, "A simple accurate expression of the reduced Fermi energy for any reduced carrier density, " J. Appl. Phys., vol. 73, 1545-1546, 1993.
- [18] H. Van Cong & B. Doan Khanh, "Simple accurate general expression of the Fermi-Dirac integral $F_j(a)$ and for $j > -1$, " Solid-State Electron., vol. 35, 949-951, 1992.
- [19] H. Van Cong, "New series representation of Fermi-Dirac integral $F_j(-\infty < a < \infty)$ for arbitrary $j > -1$, and its effect on $F_j(a \geq 0_+)$ for integer $j \geq 0$, " Solid-State Electron., vol. 34, 489-492, 1991.
- [20] H. Van Cong, S. Brunet & J.C. Martin, "Size effect on different impurity levels in semiconductors, " Solid State Communications, vol. 49, 697-699, 1984.
- [21] H. Van Cong, "Fermi energy and band-tail parameters in heavily doped semiconductors, " J. Phys. Chem. Solids, vol. 36, 1237-1240, 1975.